

Notice of References Cited	Application/Control No. 09/512,411	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Tammy T. Nguyen	Art Unit 2144	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,654,359 B1	11-2003	La Porta et al.	370/328
*	B	US-6,230,012 B1	05-2001	Willkie et al.	455/435.1
*	C	US-6,591,306	07-2003	Redlich, Jens-Peter	709/245
*	D	US-5,903,735	05-1999	Kidder et al.	709/240
*	E	US-6,047,327 A	04-2000	Tso et al.	709/232
*	F	US-5,978,678 A	11-1999	Houde et al.	455/433
*	G	US-5,878,348 A	03-1999	Foti, George	455/434
*	H	US-6,304,913 B1	10-2001	Rune, Johan	709/241
*	I	US-6,567,664 B1	05-2003	Bergenwall et al.	455/435.1
*	J	US-7,006,472 B1	02-2006	Immonen et al.	370/332
*	K	US-5,790,789	08-1998	Suarez, Larry	709/202
*	L	US-6,477,644	11-2002	Turunen, Matti	713/161
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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